

March 2005

# FDS6680AS 30V N-Channel PowerTrench<sup>®</sup> SyncFET<sup>™</sup>

## **General Description**

The FDS6680AS is designed to replace a single SO-8 MOSFET and Schottky diode in synchronous DC:DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low  $R_{\text{DS(ON)}}$  and low gate charge. The FDS6680AS includes an integrated Schottky diode using Fairchild's monolithic SyncFET technology. The performance of the FDS6680AS as the low-side switch in a synchronous rectifier is indistinguishable from the performance of the FDS6680 in parallel with a Schottky diode.

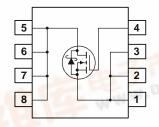
### **Applications**

- DC/DC converter
- Low side notebooks

### Features

- 11.5 A, 30 V.  $R_{DS(ON)}$  max= 10.0 m $\Omega$  @  $V_{GS}$  = 10 V  $R_{DS(ON)}$  max= 12.5 m $\Omega$  @  $V_{GS}$  = 4.5 V
- · Includes SyncFET Schottky body diode
- Low gate charge (22nC typical)
- High performance trench technology for extremely low R<sub>DS(ON)</sub> and fast switching
- High power and current handling capability





#### Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		30	V
V <sub>GSS</sub>	Gate-Source Voltage		±20	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	11.5	Α
	- Pulsed		50	- 47.V
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	3750.
		(Note 1c)	T WW	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperat	ture Range	-55 to +150	°C

#### Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
R <sub>0</sub> JC	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDS6680AS	FDS6680AS	13"	12mm	2500 units
FDS6680AS	FDS6680AS_NL (Note 4)	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA	30			V
ΔBV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 1 mA, Referenced to 25°C		29		mV/°C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			500	μА
GSS	Gate-Body Leakage	$V_{GS} = \pm 20 \text{ V},  V_{DS} = 0 \text{ V}$			±100	nA
On Char	acteristics (Note 2)					
/ <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 1$ mA	1	1.5	3	V
ΔV <sub>GS(th)</sub>	Gate Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 1 mA, Referenced to 25°C		-3		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$\begin{split} &V_{GS} = 10 \text{ V}, & I_D = 11.5 \text{ A} \\ &V_{GS} = 4.5 \text{ V}, & I_D = 9.5 \text{ A} \\ &V_{GS} = 10 \text{ V}, I_D = 11.5 \text{A}, T_J = 125 ^{\circ}\text{C} \end{split}$		8.4 10.3 12.3	10.0 12.5 15.5	mΩ
D(on)	On-State Drain Current	$V_{GS} = 10 \text{ V}, \qquad V_{DS} = 5 \text{ V}$	50			Α
<b>J</b> FS	Forward Transconductance	$V_{DS} = 15 \text{ V}, \qquad I_{D} = 11.5 \text{ A}$		48		S
Dynamic	Characteristics	•				
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		1240		pF
oss	Output Capacitance	f = 1.0 MHz		350		pF
orss .	Reverse Transfer Capacitance			120		pF
$R_G$	Gate Resistance	$V_{GS} = 15 \text{ mV}, \qquad f = 1.0 \text{ MHz}$		1.4		Ω
Switchin	g Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time			9	18	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DS} = 15 \text{ V}, \qquad I_{D} = 1 \text{ A},$		5	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		27	42	ns
t <sub>f</sub>	Turn-Off Fall Time			11	21	ns
t <sub>d(on)</sub>	Turn-On Delay Time			11	20	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DS} = 15 \text{ V}, \qquad I_{D} = 1 \text{ A},$		12	22	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		18	32	ns
t <sub>f</sub>	Turn-Off Fall Time			11	20	ns
Q <sub>g(TOT)</sub>	Total Gate Charge at Vgs=10V			22	30	nC
$Q_g$	Total Gate Charge at Vgs=5V	$V_{DD} = 15 \text{ V},  I_D = 11.5 \text{ A},$		12	16	nC
Q <sub>gs</sub>	Gate-Source Charge	7		3.5		nC
$Q_{qd}$	Gate-Drain Charge			3.4		nC

#### **Electrical Characteristics** TA = 25°C unless otherwise noted **Symbol Parameter Test Conditions** Min Typ Max **Units Drain-Source Diode Characteristics and Maximum Ratings** Maximum Continuous Drain-Source Diode Forward Current $I_{S}$ 3.5 Α $\overline{V_{GS}} = 0 \text{ V}, \quad I_{S} = 3.5 \text{ A}$ $V_{\text{SD}} \\$ Drain-Source Diode Forward 0.5 0.7 (Note 2) Voltage $V_{GS} = 0 V$ , 0.6 $I_S = 7 A$ (Note 2) T<sub>rr</sub> $I_{\rm F} = 11.5A$ Diode Reverse Recovery Time 18 nS $Q_{rr}$ Diode Reverse Recovery Charge $d_{iF}/d_t = 300 \text{ A/}\mu\text{s}$ 12 nC (Note 3)

#### Notes

1. R<sub>0JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



 a) 50°/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b) 105°/W when mounted on a .04 in<sup>2</sup> pad of 2 oz copper



c) 125°/W when mounted on a minimum pad.

- Scale 1:1 on letter size paper
- 2. Pulse Test: Pulse Width <  $300\mu s$ , Duty Cycle < 2.0%
- 3. See "SyncFET Schottky body diode characteristics" below.
- 4. FDS6680AS\_NL is a lead free product. The FDS6680AS\_NL marking will appear on the reel label.

# **Typical Characteristics**

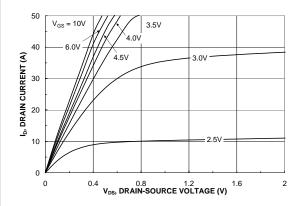


Figure 1. On-Region Characteristics.

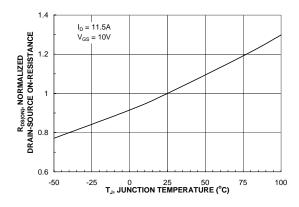


Figure 3. On-Resistance Variation with Temperature.

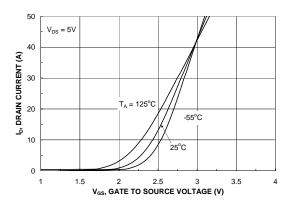


Figure 5. Transfer Characteristics.

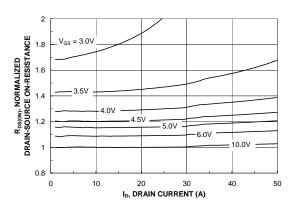


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

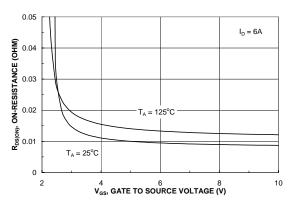


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

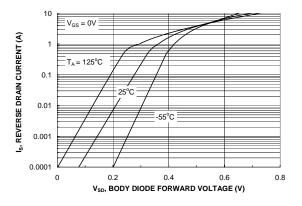
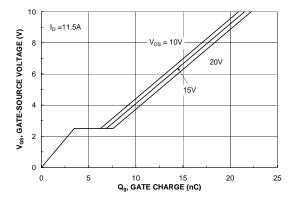


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# **Typical Characteristics** (continued)



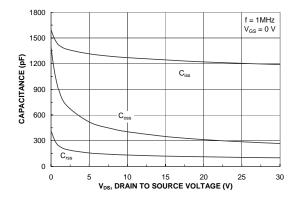
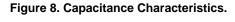
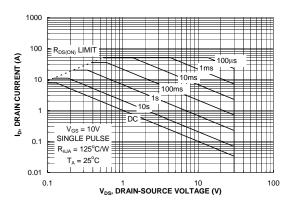


Figure 7. Gate Charge Characteristics.





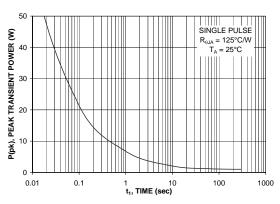


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

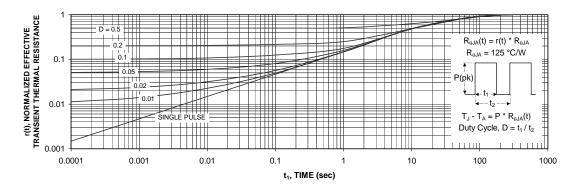


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

## Typical Characteristics (continued)

# SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 shows the reverse recovery characteristic of the FDS6680AS.

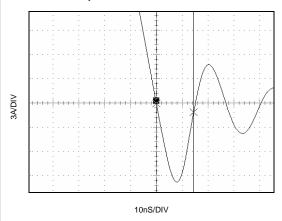


Figure 12. FDS6680AS SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS6680).

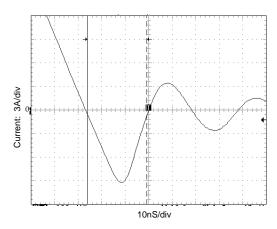


Figure 13. Non-SyncFET (FDS6680) body diode reverse recovery characteristic.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

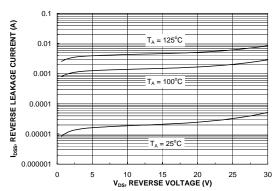
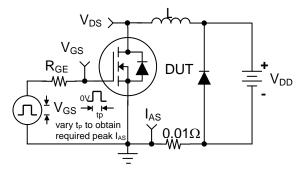


Figure 14. SyncFET body diode reverse leakage versus drain-source voltage and temperature.

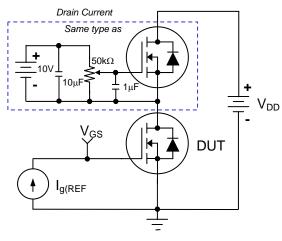
# **Typical Characteristics**



BV<sub>DSS</sub>
V<sub>DS</sub>
V<sub>DD</sub>

Figure 15. Unclamped Inductive Load Test Circuit

Figure 16. Unclamped Inductive Waveforms



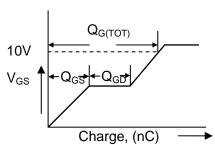
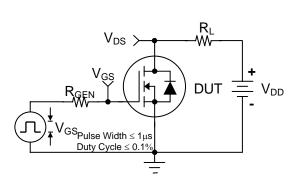


Figure 17. Gate Charge Test Circuit

Figure 18. Gate Charge Waveform



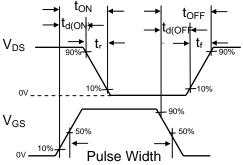


Figure 19. Switching Time Test Circuit

Figure 20. Switching Time Waveforms

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	DOME™	GTO™ .	MicroPak™	QFET®	SuperSOT™-8
	EcoSPARK™	HiSeC™	MICROWIRE™	QS™	SyncFET™
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